

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/683,714	LEHMKUHL ET AL.	
		Examiner	Art Unit	
		Alfred E. Dudding	2853	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,441,352 A	08-1995	Shiota, Junji	400/621
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	X	

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Notice of References Cited		Application/Control No. 09/683,714	Applicant(s)/Patent Under Reexamination LEHMKUHL ET AL.	
		Examiner Alfred E. Dudding	Art Unit 2853	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,497,183 A	03-1996	Yoshida et al.	347/215
	B	US-5,451,996 A	09-1995	Awai et al.	347/214
	C	US-3,761,675 A	09-1973	Mason et al.	219/121LM
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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